

MC78LXXA/LM78LXXA

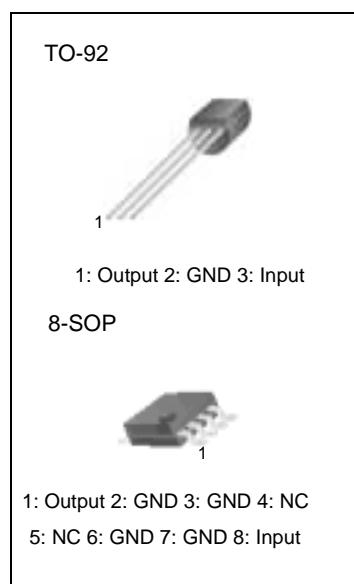
3-terminal 0.1A positive voltage regulator

Features

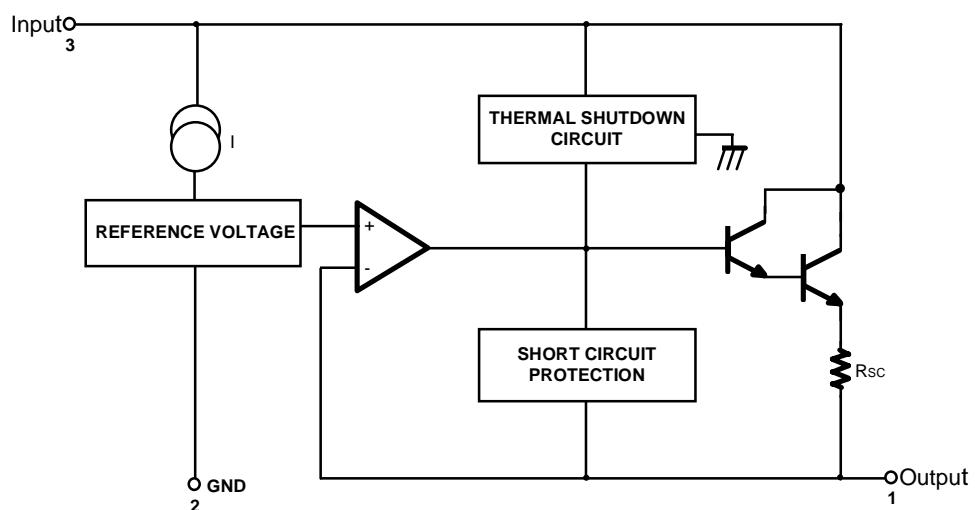
- Maximum Output Current of 100mA
- Output Voltage of 5V, 6V, 8V, 9V, 10V, 12V, 15V, 18V and 24V
- Thermal Overload Protection
- Short Circuit Current Limiting
- Output Voltage Offered in $\pm 5\%$ Tolerance

Description

The MC78LXXA/LM78LXXA series of fixed voltage monolithic integrated circuit voltage regulators are suitable for application that required supply current up to 100mA.



Internal Block Diagram



Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Input Voltage (for $V_O = 5V, 8V$) (for $V_O = 12V$ to $18V$) (for $V_O = 24V$)	V_I	30 35 40	V
Operating Junction Temperature Range	T_J	0 ~ +150	°C
Storage Temperature Range	T_{STG}	-65 ~ +150	°C

Electrical Characteristics(MC78L05A/LM78L05A)

($V_I = 10V$, $I_O = 40mA$, $0^\circ C \leq T_J \leq 125^\circ C$, $C_I = 0.33 \mu F$, $C_O = 0.1 \mu F$, unless otherwise specified. (Note 1)

Parameter	Symbol	Conditions		Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = 25^\circ C$		4.8	5.0	5.2	V
Line Regulation	ΔV_O	$T_J = 25^\circ C$	$7V \leq V_I \leq 20V$	-	8	150	mV
			$8V \leq V_I \leq 20V$	-	6	100	mV
Load Regulation	ΔV_O	$T_J = 25^\circ C$	$1mA \leq I_O \leq 100mA$	-	11	60	mV
			$1mA \leq I_O \leq 40mA$	-	5.0	30	mV
Output Voltage	V_O	$7V \leq V_I \leq 20V$	$1mA \leq I_O \leq 40mA$	-	-	5.25	V
		$7V \leq V_I \leq V_{MAX}$ (Note 2)	$1mA \leq I_O \leq 70mA$	4.75	-	5.25	V
Quiescent Current	I_Q	$T_J = 25^\circ C$		-	2.0	5.5	mA
Quiescent Current Change	with line	ΔI_Q	$8V \leq V_I \leq 20V$	-	-	1.5	mA
	with load	ΔI_Q	$1mA \leq I_O \leq 40 mA$	-	-	0.1	mA
Output Noise Voltage	V_N	$T_A = 25^\circ C$, $10Hz \leq f \leq 100KHz$		-	40	-	µV
Temperature Coefficient of V_O	$\Delta V_O/\Delta T$	$I_O = 5mA$		-	-0.65	-	mV/ °C
Ripple Rejection	RR	$f = 120Hz$, $8V \leq V_I \leq 18V$, $T_J = 25^\circ C$		41	80	-	dB
Dropout Voltage	V_D	$T_J = 25^\circ C$		-	1.7	-	V

Notes:

- The maximum steady state usable output current and input voltage are very dependent on the heat sinking and/or lead length of the package. The data above represent pulse test conditions with junction temperature as indicated at the initiation of tests.
- Power dissipation $\leq 0.75W$.

Electrical Characteristics(MC78L08A)

($V_I = 14V$, $I_O = 40mA$, $0^\circ C \leq T_J \leq 125^\circ C$, $C_I = 0.33\ \mu F$, $C_O = 0.1\ \mu F$, unless otherwise specified. (Note 1)

Parameter	Symbol	Conditions		Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = 25^\circ C$		7.7	8.0	8.3	V
Line Regulation	ΔV_O	$T_J = 25^\circ C$	$10.5V \leq V_I \leq 23V$	-	10	175	mV
			$11V \leq V_I \leq 23V$	-	8	125	mV
Load Regulation	ΔV_O	$T_J = 25^\circ C$	$1mA \leq I_O \leq 100mA$	-	15	80	mV
			$1mA \leq I_O \leq 40mA$	-	8.0	40	mV
Output Voltage	V_O	$10.5V \leq V_I \leq 23V$	$1mA \leq I_O \leq 40mA$	7.6	-	8.4	V
		$10.5V \leq V_I \leq V_{MAX}$ (Note 2)	$1mA \leq I_O \leq 70mA$	7.6	-	8.4	V
Quiescent Current	I_Q	$T_J = 25^\circ C$		-	2.0	5.5	mA
Quiescent Current Change	with line	ΔI_Q	$11V \leq V_I \leq 23V$		-	-	1.5 mA
	with load	ΔI_Q	$1mA \leq I_O \leq 40mA$		-	-	0.1 mA
Output Noise Voltage	V_N	$T_A = 25^\circ C$, $10Hz \leq f \leq 100KHz$		-	60	-	μV
Temperature Coefficient of V_O	$\Delta V_O/\Delta T$	$I_O = 5mA$		-	-0.8	-	$mV/^\circ C$
Ripple Rejection	RR	$f = 120Hz$, $11V \leq V_I \leq 21V$, $T_J = 25^\circ C$		39	70	-	dB
Dropout Voltage	V_D	$T_J = 25^\circ C$		-	1.7	-	V

Notes:

1. The maximum steady state usable output current and input voltage are very dependent on the heat sinking and/or lead length of the package. The data above represent pulse test conditions with junction temperature as indicated at the initiation of tests.
2. Power dissipation $\leq 0.75W$.

Electrical Characteristics(MC78L12A/LM78L12A)

($V_I = 19V$, $I_O = 40mA$, $0^\circ C \leq T_J \leq 125^\circ C$, $C_I = 0.33\ \mu F$, $C_O = 0.1\ \mu F$, unless otherwise specified. (Note 1)

Parameter	Symbol	Conditions		Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = 25^\circ C$		11.5	12	12.5	V
Line Regulation	ΔV_O	$T_J = 25^\circ C$	$14.5V \leq V_I \leq 27V$	-	20	250	mV
			$16V \leq V_I \leq 27V$	-	15	200	mV
Load Regulation	ΔV_O	$T_J = 25^\circ C$	$1mA \leq I_O \leq 100mA$	-	20	100	mV
			$1mA \leq I_O \leq 40mA$	-	10	50	mV
Output Voltage	V_O	$14.5V \leq V_I \leq 27V$	$1mA \leq I_O \leq 40mA$	11.4	-	12.6	V
		$14.5V \leq V_I \leq V_{MAX}$ (Note 2)	$1mA \leq I_O \leq 70mA$	11.4	-	12.6	V
Quiescent Current	I_Q	$T_J = 25^\circ C$		-	2.1	6.0	mA
Quiescent Current Change	with line	ΔI_Q	$16V \leq V_I \leq 27V$		-	-	1.5 mA
	with load	ΔI_Q	$1mA \leq I_O \leq 40mA$		-	-	0.1 mA
Output Noise Voltage	V_N	$T_A = 25^\circ C$, $10Hz \leq f \leq 100KHz$		-	80	-	μV
Temperature Coefficient of V_O	$\Delta V_O/\Delta T$	$I_O = 5mA$		-	-1.0	-	$mV/^\circ C$
Ripple Rejection	RR	$f = 120Hz$, $15V \leq V_I \leq 25V$, $T_J = 25^\circ C$		37	65	-	dB
Dropout Voltage	V_D	$T_J = 25^\circ C$		-	1.7	-	V

Notes:

1. The maximum steady state usable output current and input voltage are very dependent on the heat sinking and/or lead length of the package. The data above represent pulse test conditions with junction temperature as indicated at the initiation of tests.
2. Power dissipation $\leq 0.75W$.

Electrical Characteristics(MC78L15A)

($V_I = 23V$, $I_O = 40mA$, $0^\circ C \leq T_J \leq 125^\circ C$, $C_I = 0.33\ \mu F$, $C_O = 0.1\ \mu F$, unless otherwise specified. (Note 1)

Parameter	Symbol	Conditions		Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = 25^\circ C$		14.4	15	15.6	V
Line Regulation	ΔV_O	$T_J = 25^\circ C$	$17.5V \leq V_I \leq 30V$	-	25	300	mV
			$20V \leq V_I \leq 30V$	-	20	250	mV
Load Regulation	ΔV_O	$T_J = 25^\circ C$	$1mA \leq I_O \leq 100mA$	-	25	150	mV
			$1mA \leq I_O \leq 40mA$	-	12	75	mV
Output Voltage	V_O	$17.5V \leq V_I \leq 30V$	$1mA \leq I_O \leq 40mA$	14.25	-	15.75	V
		$17.5V \leq V_I \leq V_{MAX}$ (Note 2)	$1mA \leq I_O \leq 70mA$	14.25	-	15.75	V
Quiescent Current	I_Q	$T_J = 25^\circ C$		-	2.1	6.0	mA
Quiescent Current Change	with line	ΔI_Q	$20V \leq V_I \leq 30V$		-	-	1.5 mA
	with load	ΔI_Q	$1mA \leq I_O \leq 40mA$		-	-	0.1 mA
Output Noise Voltage	V_N	$T_A = 25^\circ C$, $10Hz \leq f \leq 100KHz$		-	90	-	μV
Temperature Coefficient of V_O	$\Delta V_O/\Delta T$	$I_O = 5mA$		-	-1.3	-	$mV/^\circ C$
Ripple Rejection	RR	$f = 120Hz$, $18.5V \leq V_I \leq 28.5V$, $T_J = 25^\circ C$		34	60	-	dB
Dropout Voltage	V_D	$T_J = 25^\circ C$		-	1.7	-	V

Notes:

1. The maximum steady state usable output current and input voltage are very dependent on the heat sinking and/or lead length of the package. The data above represent pulse test conditions with junction temperature as indicated at the initiation of tests.
2. Power dissipation $\leq 0.75W$.

Electrical Characteristics(MC78L18A)

(VI = 27V, IO = 40mA, 0 °C ≤ TJ ≤ 125 °C, CI = 0.33 µF, CO = 0.1µF, unless otherwise specified. (Note 1)

Parameter	Symbol	Conditions		Min.	Typ.	Max.	Unit
Output Voltage	VO	TJ = 25 °C		17.3	18	18.7	V
Line Regulation	ΔVO	TJ = 25 °C	21V ≤ VI ≤ 33V	-	145	300	mV
			22V ≤ VI ≤ 33V	-	135	250	mV
Load Regulation	ΔVO	TJ = 25 °C	1mA ≤ IO ≤ 100mA	-	30	170	mV
			1mA ≤ IO ≤ 40mA	-	15	85	mV
Output Voltage	VO	21V ≤ VI ≤ 33V	1mA ≤ IO ≤ 40mA	17.1	-	18.9	V
		21V ≤ VI ≤ VMAX (Note 2)	1mA ≤ IO ≤ 70mA	17.1	-	18.9	V
Quiescent Current	IQ	TJ = 25 °C		-	2.2	6.0	mA
Quiescent Current Change	with line	ΔIQ	21V ≤ VI ≤ 33V		-	-	1.5 mA
	with load	ΔIQ	1mA ≤ IO ≤ 40mA		-	-	0.1 mA
Output Noise Voltage	VN	TA = 25 °C, 10Hz ≤ f ≤ 100KHz		-	150	-	µV
Temperature Coefficient of VO	ΔVO/ΔT	IO = 5mA		-	-1.8	-	mV/ °C
Ripple Rejection	RR	f = 120Hz, 23V ≤ VI ≤ 33V, TJ = 25 °C		34	48	-	dB
Dropout Voltage	VD	TJ = 25 °C		-	1.7	-	V

Notes:

1. The maximum steady state usable output current and input voltage are very dependent on the heat sinking and/or lead length of the package. The data above represent pulse test conditions with junction temperature as indicated at the initiation of tests.
2. Power dissipation ≤ 0.75W.

Electrical Characteristics(MC78L24A)

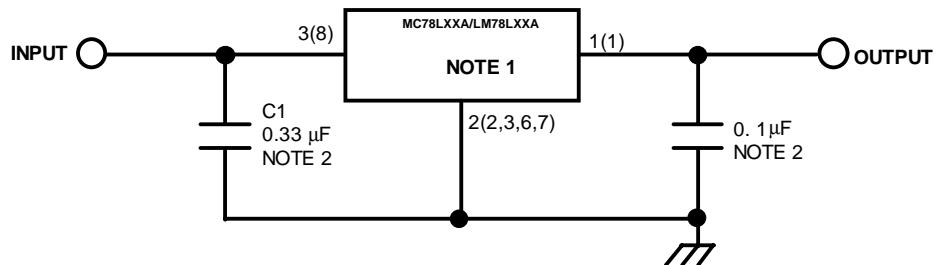
($V_I = 33V$, $I_O = 40mA$, $0^\circ C \leq T_J \leq 125^\circ C$, $C_I = 0.33\ \mu F$, $C_O = 0.1\ \mu F$, unless otherwise specified. (Note 1)

Parameter	Symbol	Conditions		Min.	Typ.	Max.	Unit
Output Voltage	V_O	$T_J = 25^\circ C$		23	24	25	V
Line Regulation	ΔV_O	$T_J = 25^\circ C$	$27V \leq V_I \leq 38V$	-	160	300	mV
			$28V \leq V_I \leq 38V$	-	150	250	mV
Load Regulation	ΔV_O	$T_J = 25^\circ C$	$1mA \leq I_O \leq 100mA$	-	40	200	mV
			$1mA \leq I_O \leq 40mA$	-	20	100	mV
Output Voltage	V_O	$27V \leq V_I \leq 38V$	$1mA \leq I_O \leq 40mA$	22.8	-	25.2	V
		$27V \leq V_I \leq V_{MAX}$ (Note 2)	$1mA \leq I_O \leq 70mA$	22.8	-	25.2	V
Quiescent Current	I_Q	$T_J = 25^\circ C$		-	2.2	6.0	mA
Quiescent Current Change	with line	ΔI_Q	$28V \leq V_I \leq 38V$		-	-	1.5 mA
	with load	ΔI_Q	$1mA \leq I_O \leq 40mA$		-	-	0.1 mA
Output Noise Voltage	V_N	$T_A = 25^\circ C$, $10Hz \leq f \leq 100KHz$		-	200	-	μV
Temperature Coefficient of V_O	$\Delta V_O/\Delta T$	$I_O = 5mA$		-	-2.0	-	$mV/^\circ C$
Ripple Rejection	RR	$f = 120Hz$, $28V \leq V_I \leq 38V$, $T_J = 25^\circ C$		34	45	-	dB
Dropout Voltage	V_D	$T_J = 25^\circ C$		-	1.7	-	V

Notes:

1. The maximum steady state usable output current and input voltage are very dependent on the heat sinking and/or lead length of the package. The data above represent pulse test conditions with junction temperature as indicated at the initiation of tests.
2. Power dissipation $\leq 0.75W$.

Typical Application



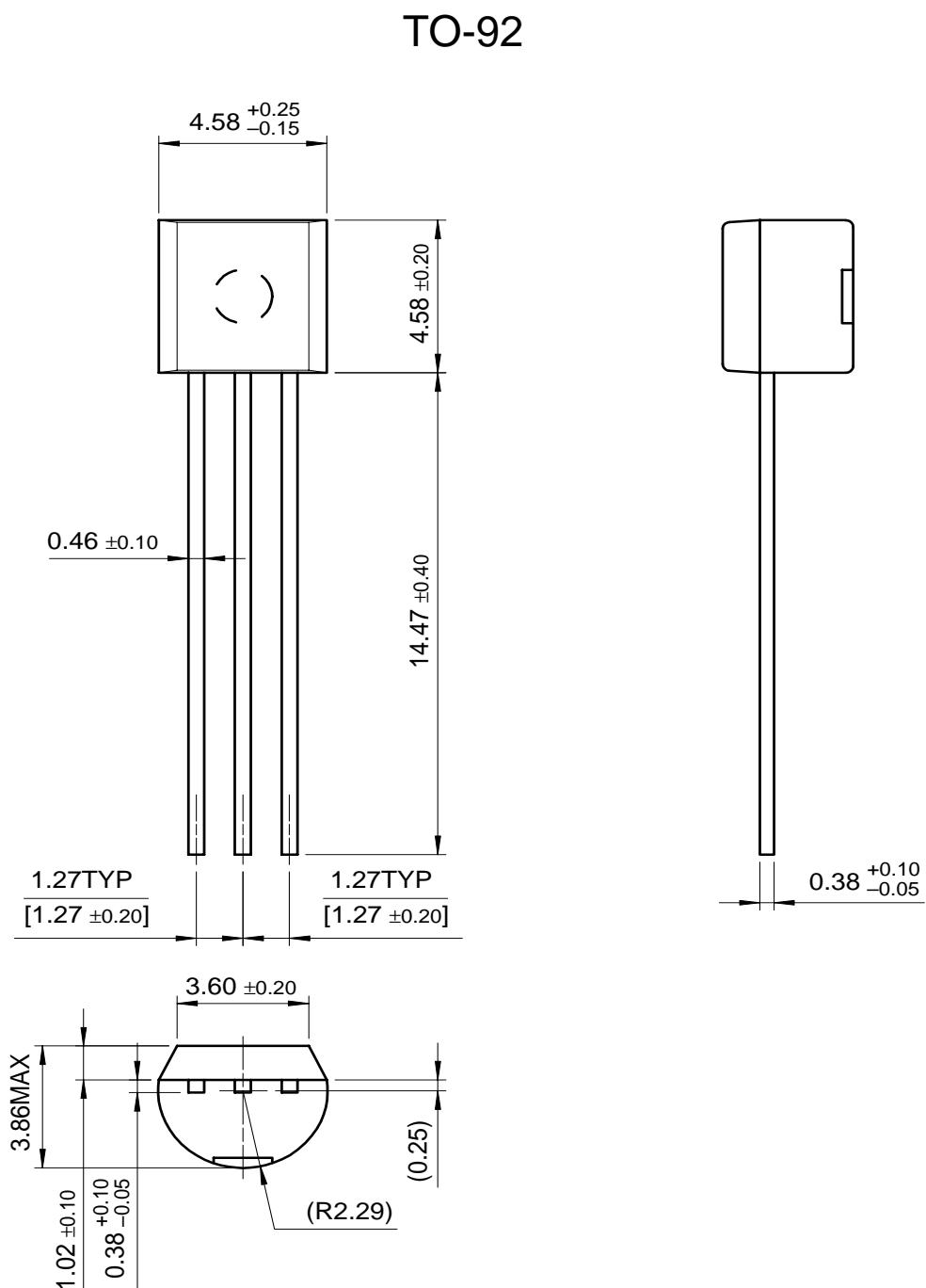
'()' : 8SOP Type

Notes:

1. To specify an output voltage, substitute voltage value for "XX".
2. Bypass Capacitors are recommended for optimum stability and transient response and should be located as close as possible to the regulator.

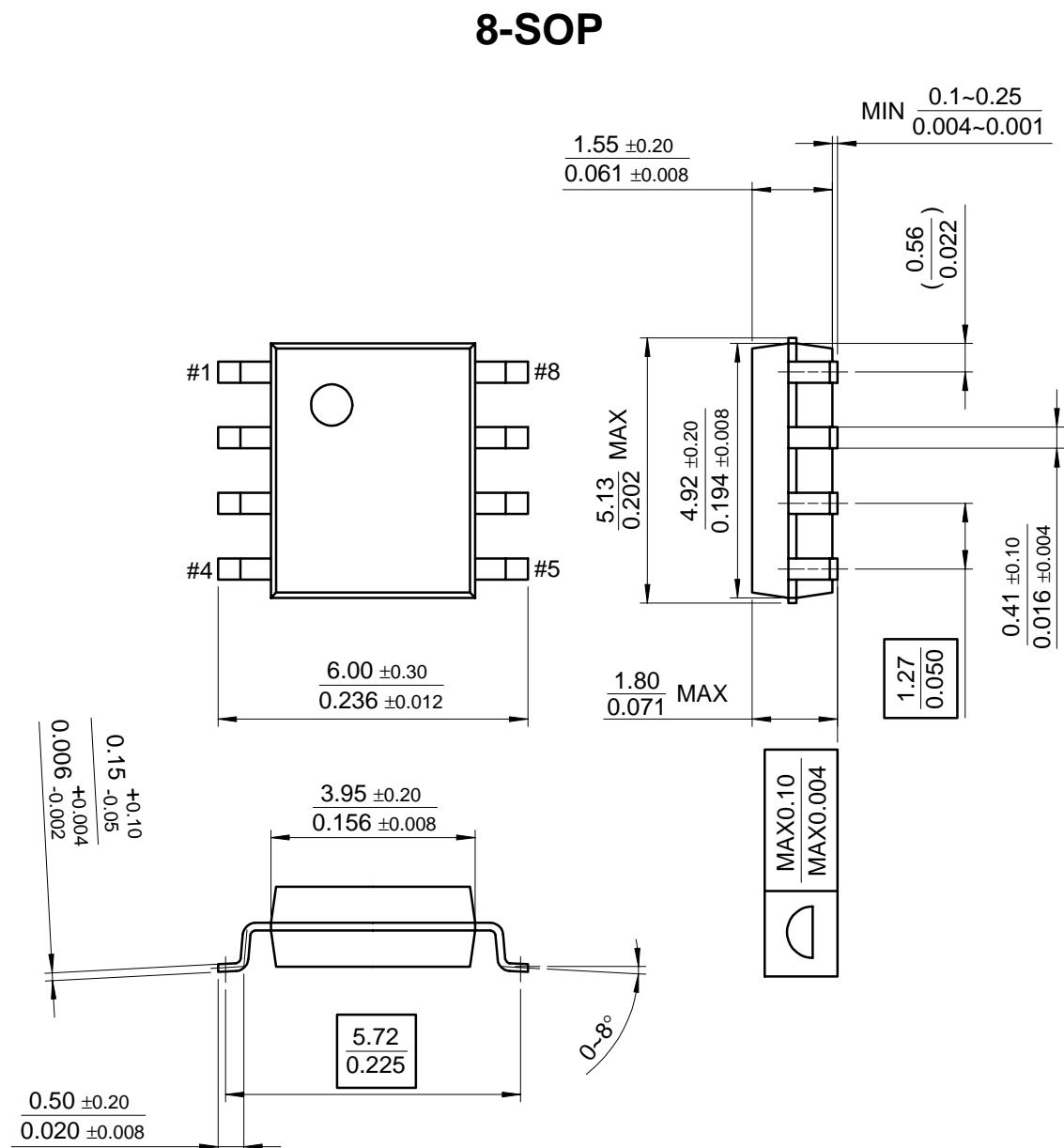
Mechanical Dimensions

Package



Mechanical Dimensions (Continued)

Package



Ordering Information

Product Number	Package	Operating Temperature
LM78L05ACZ	TO-92	0 ~ + 125 °C
LM78L12ACZ		

Product Number	Package	Operating Temperature
MC78L05ACP	TO-92	0 ~ + 125 °C
MC78L08ACP		
MC78L12ACP		
MC78L15ACP		
MC78L18ACP		
MC78L24ACP		
MC78L05ACD	8 SOP	

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